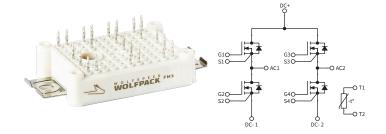


1200 V, 21 m Ω , Silicon Carbide, Full-Bridge Module

$\mathbf{V}_{\mathtt{DS}}$	1200 V
$R_{DS(on)}$	21 mΩ

Technical Features

- Ultra-Low Loss
- High Frequency Operation
- Zero Turn-Off Tail Current from MOSFET
- Normally-Off, Fail-Safe Device Operation



Applications

- DC-DC Converters
- EV Chargers
- High-Efficiency Converters / Inverters
- Renewable Energy
- Smart-Grid / Grid-Tied Distributed Generation

System Benefits

- Enables Compact, Lightweight Systems
- Increased System Efficiency, due to Low Switching & Conduction Losses of SiC
- Reduced Thermal Requirements and System Cost

Maximum Parameters (Verified by Design)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Test Conditions	Note	
Drain-Source Voltage	V _{DS}			1200				
Gate-Source Voltage, Maximum Value	V _{GS max}	-8		+19	V	Transient, < 100 ns	F:~ 22	
Gate-Source Voltage, Recommended	V _{GS op}	-4		+15		Static	Fig. 32	
DC Continuous Drain Current (T _{VJ} ≤ 150 °C)			48			$V_{GS} = 15 \text{ V}, T_{HS} = 50 \text{ °C}, T_{VJ} \le 150 \text{ °C}$	F:- 20	
DC Continuous Drain Current (T _{VJ} ≤ 175 °C)	I _D			50	А	$V_{GS} = 15 \text{ V}, T_{HS} = 50 \text{ °C}, T_{VJ} \le 175 \text{ °C}$	Fig. 20	
DC Source-Drain Current (Body Diode)	I _{SD BD}		24			$V_{GS} = -4 \text{ V}, \ T_{HS} = 50 \text{ °C}, T_{VJ} \le 175 \text{ °C}$		
Pulsed Drain Current	I _{D (pulsed)}			100		t _{Pmax} limited by T _{VJmax} V _{GS} = 15 V, T _{HS} = 50 °C		
Virtual Junction Temperature	_	-40		150	°C	Operation		
	T _{VJ op}	-40		175		Intermittent with Reduced Life		

MOSFET Characteristics (Per Position) ($T_{yJ} = 25$ °C unless otherwise specified)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Test Conditions	Note	
Drain-Source Breakdown Voltage	V _{(BR)DSS}	1200				V _{GS} = 0 V, T _{VJ} = -40 °C		
	V _{GS(th)}	1.8	2.5	3.9	V	$V_{DS} = V_{GS}$, $I_D = 17 \text{ mA}$		
Gate Threshold Voltage			2.0			$V_{DS} = V_{GS}$, $I_D = 17$ mA, $T_{VJ} = 150$ °C		
Zero Gate Voltage Drain Current	I _{DSS}		1	25	μΑ	V _{GS} = 0 V, V _{DS} = 1200 V		
Gate-Source Leakage Current	I _{GSS}		10	100	nA	$V_{GS} = 15 \text{ V}, V_{DS} = 0 \text{ V}$		
			21.0	28.9		$V_{GS} = 15 \text{ V}, I_D = 30 \text{ A}$		
Drain-Source On-State Resistance (Devices Only)	R _{DS(on)}		32.8		mΩ	$V_{GS} = 15 \text{ V}, I_D = 30 \text{ A}, T_{VJ} = 150 ^{\circ}\text{C}$	Fig. 2 Fig. 3	
(Devices Only)			38.0		-	$V_{GS} = 15 \text{ V}, I_D = 30 \text{ A}, T_{VJ} = 175 ^{\circ}\text{C}$		
Transconductance	g _{fs}		26		S	$V_{DS} = 20 \text{ V}, I_{D} = 30 \text{ A}$	- Fig. 4	
			27			$V_{DS} = 20 \text{ V}, I_D = 30 \text{ A}, T_{VJ} = 150 ^{\circ}\text{C}$		
Turn-On Switching Energy, T_{VJ} = 25 °C T_{VJ} = 125 °C T_{VJ} = 150 °C	Eon		0.54 0.65 0.69			$V_{DD} = 600 \text{ V},$ $I_D = 30 \text{ A},$	Fig. 11 Fig. 13	
Turn-Off Switching Energy, T_{VJ} = 25 °C T_{VJ} = 125 °C T_{VJ} = 150 °C	E _{off}		0.043 0.064 0.068		mJ	$\begin{split} &V_{GS}=-4 \text{ V/15 V,} \\ &R_{G(OFF)}=0.0 \ \Omega, R_{G(ON)}=2.0 \ \Omega, \\ &L=22.7 \ \mu H \end{split}$		
Internal Gate Resistance	R _{G(int)}		3.3		Ω	f = 100 kHz, V _{AC} = 25 mV		
Input Capacitance	C _{iss}		5.4				Fig. 9	
Output Capacitance	C _{oss}		0.20		nF	$V_{GS} = 0 \text{ V}, V_{DS} = 1000 \text{ V},$ $V_{AC} = 25 \text{ mV}, f = 100 \text{ kHz}$		
Reverse Transfer Capacitance	C _{rss}		17		pF	V _{AC} – 25 IIIV, I – 100 KHZ		
Gate to Source Charge	Q _{GS}		49			V _{DS} = 800 V, V _{GS} = -4 V/15 V,		
Gate to Drain Charge	Q_{GD}		50		nC	$I_D = 40 \text{ A},$		
Total Gate Charge	Q _G		162			Per IEC60747-8-4 pg 21		
FET Thermal Resistance, Junction to Heatsink	R _{th JHS}		1.27		°C/W		Fig. 17	

Diode Characteristics (Per Position) (T_{VJ} = 25 °C unless otherwise specified)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Test Conditions	Notes
Body Diode Forward Voltage	.,		4.9		V	V _{GS} = -4 V, I _{SD} = 30 A	F:~ 7
	V_{SD}		4.4			V _{GS} = -4 V, I _{SD} = 30 A, T _{VJ} = 150 °C	− Fig. 7
Reverse Recovery Time	t _{RR}		19		ns		' Fig. 33
Reverse Recovery Charge	Q _{RR}		0.9		μC	$V_{GS} = -4 \text{ V}, I_{SD} = 30 \text{ A}, V_{R} = 600 \text{ V},$ $di/dt = 8 \text{ A/ns}, T_{VJ} = 150 ^{\circ}\text{C}$	
Peak Reverse Recovery Current	I _{RRM}		74		Α	- di/dt = 0 /4/113, 1/1/ = 130 °C	
Reverse Recovery Energy, $T_{VJ} = 25 ^{\circ}\text{C}$ $T_{VJ} = 125 ^{\circ}\text{C}$ $T_{VJ} = 150 ^{\circ}\text{C}$	E _{RR}		0.04 0.08 0.09		mJ	$V_{DD} = 600 \text{ V}, \ I_D = 30 \text{ A}, \ V_{GS} = -4 \text{ V}/15 \text{ V}, \ R_{G(ON)} = 2.0 \ \Omega, \ L = 22.7 \ \mu\text{H}$	Fig. 14

Module Physical Characteristics

Parameter	Symbol	Min.	Тур.	Max.	Unit	Test Conditions
Package Resistance, M1, M3 (High-Side)	R _{HS}		1.6		0	T _c = 125°C, Note 1
Package Resistance, M2, M4 (Low-Side)	R _{LS}		1.5		mΩ	T _c = 125°C, Note 1
Stray Inductance	L_{Stray}		14.2		nH	Between DC- and DC+, f = 10 MHz
Case Temperature	T _c	-40		125	°C	
Mounting Torque	Ms		2.0	2.3	N-m	M4 bolts
Weight	W		21		g	
Case Isolation Voltage	V _{isol}	3			kV	AC, 50 Hz, 1 minute
Comparative Tracking Index	CTI	200				
Classen as Distance			5.0			Terminal to Terminal
Clearance Distance			10.0		mm	Terminal to Heatsink
Creepage Distance			6.3		mm	Terminal to Terminal
			11.5			Terminal to Heatsink

Motas.

NTC Thermistor Characterization

Parameter	Symbol	Min.	Тур.	Max.	Unit	Test Conditions
Rated Resistance	R _{NTC}		5.0		kΩ	T _{NTC} = 25°C
Resistance Tolerance at 25 °C	ΔR/R	-5		5	%	
Beta Value (T ₂ = 50 °C)	β _{25/50}		3380		K	
Beta Value (T ₂ = 80 °C)	β _{25/80}		3468		K	
Beta Value (T ₂ = 100 °C)	β _{25/100}		3523		K	
Power Dissipation	P _{Max}			10	mW	T _{NTC} = 25°C

¹Total Effective Resistance (Per Switch Position) = MOSFET R_{DS(on)} + Switch Position Package Resistance

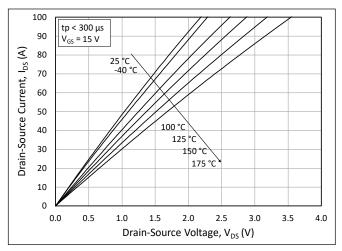


Figure 1. Output Characteristics for Various Junction Temperatures

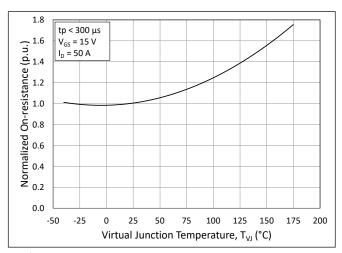


Figure 3. Normalized On-State Resistance vs. Junction Temperature

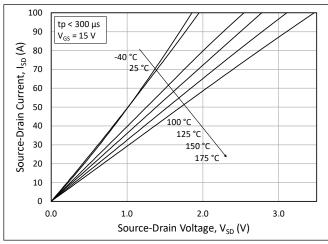


Figure 5. 3^{rd} Quadrant Characteristic vs. Junction Temperatures at $V_{GS} = 15 \text{ V}$

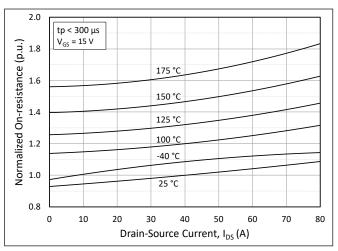


Figure 2. Normalized On-State Resistance vs. Drain Current for Various Junction Temperatures

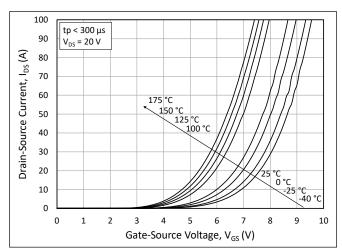


Figure 4. Transfer Characteristic for Various Junction Temperatures

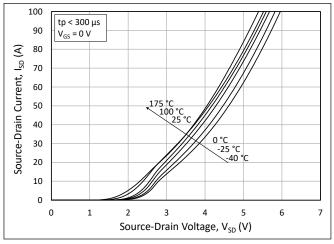


Figure 6. 3^{rd} Quadrant Characteristic vs. Junction Temperatures at $V_{GS} = 0 \text{ V}$

5

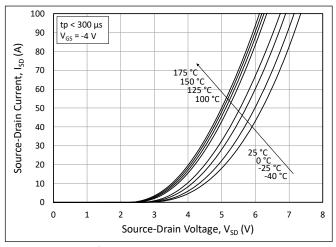


Figure 7. 3^{rd} Quadrant Characteristic vs. Junction Temperatures at $V_{GS} = -4 \text{ V (Body Diode)}$

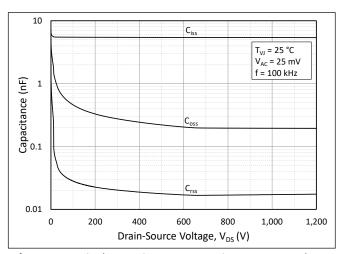


Figure 9. Typical Capacitances vs. Drain to Source Voltage (0 - 1200 V)

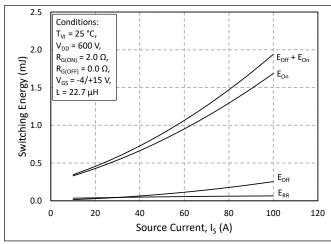


Figure 11. Switching Energy vs. Drain Current (V_{DD} = 600 V)

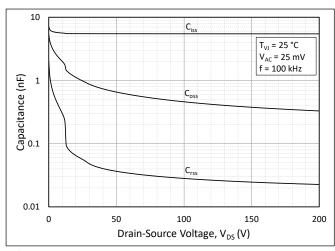


Figure 8. Typical Capacitances vs. Drain to Source Voltage (0 - 200 V)

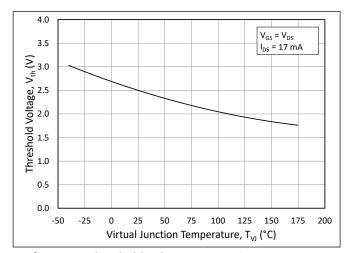


Figure 10. Threshold Voltage vs. Junction Temperature

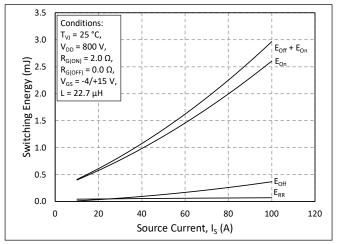


Figure 12. Switching Energy vs. Drain Current (V_{DD} = 800 V)

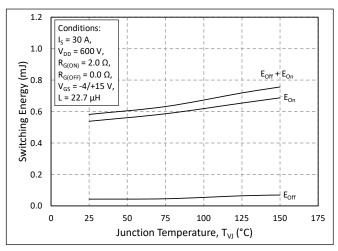


Figure 13. MOSFET Switching Energy vs. Junction Temperature

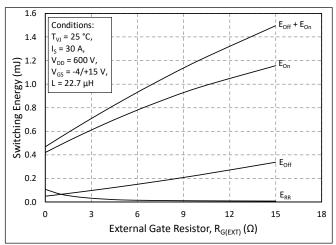


Figure 15. MOSFET Switching Energy vs. External Gate Resistance

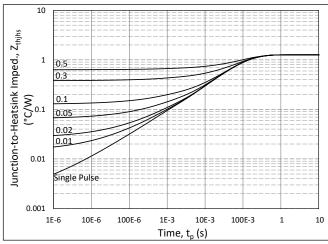


Figure 17. MOSFET Junction to Heatsink Transient Thermal Impedance, $Z_{th\,JHS}$ (°C/W)

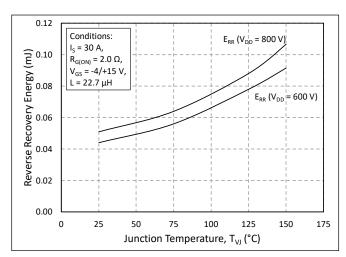


Figure 14. Reverse Recovery Energy vs. Junction Temperature

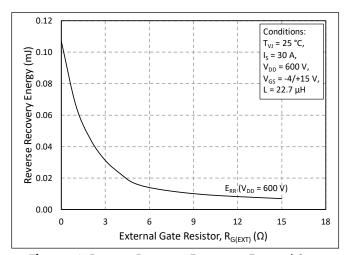


Figure 16. Reverse Recovery Energy vs. External Gate Resistance

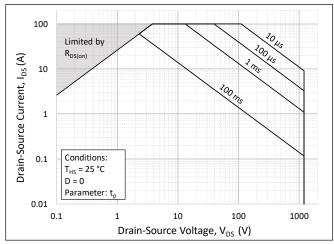


Figure 18. Forward Bias Safe Operating Area (FBSOA)

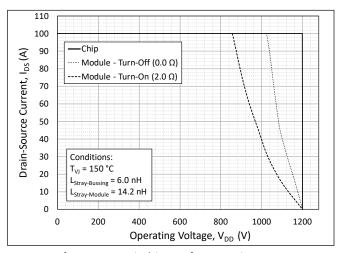


Figure 19. Switching Safe Operating Area

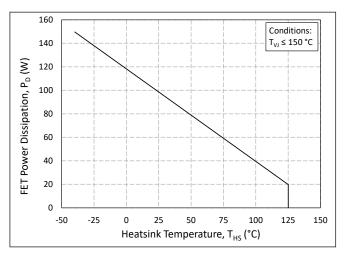


Figure 21. Maximum Power Dissipation Derating vs. Heatsink Temperature

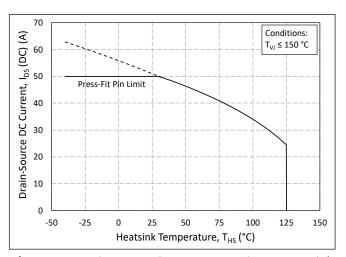


Figure 20. Continuous Drain Current Derating vs. Heatsink Temperature

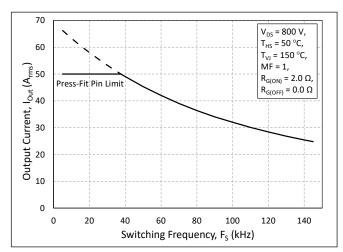


Figure 22. Typical Output Current Capability vs. Switching Frequency (Inverter Application)

8

Timing Characteristics

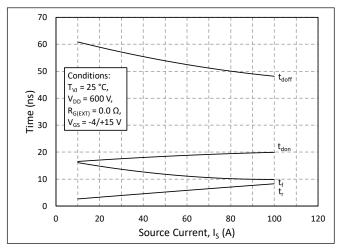


Figure 23. Timing vs. Source Current

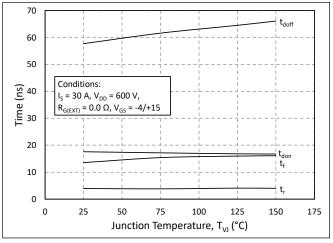


Figure 25. Timing vs. Junction Temperature

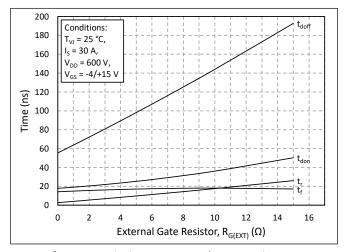


Figure 27. Timing vs. External Gate Resistance

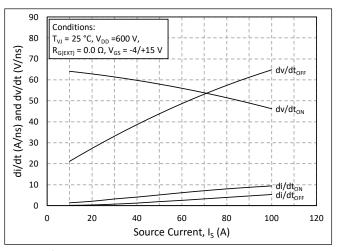


Figure 24. dv/dt and di/dt vs. Source Current

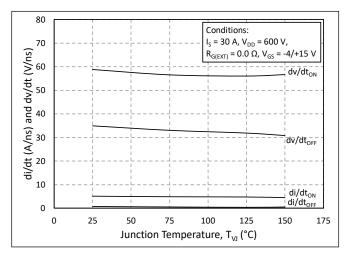


Figure 26. dv/dt and di/dt vs. Junction Temperature

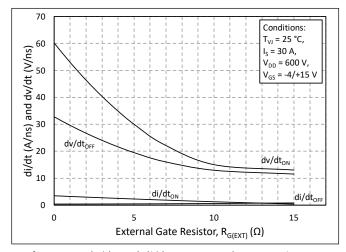


Figure 28. dv/dt and di/dt vs. External Gate Resistance

Definitions

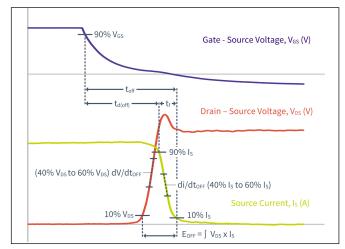


Figure 29. Turn-off Transient Definitions

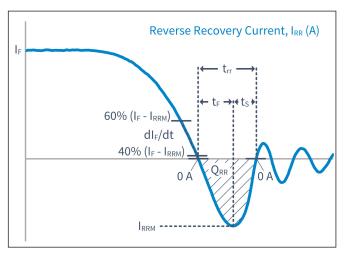


Figure 31. Reverse Recovery Definitions

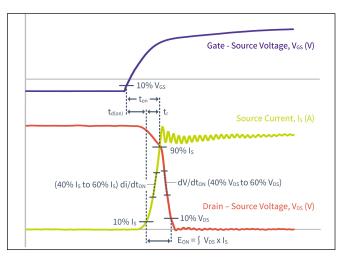


Figure 30. Turn-on Transient Definitions

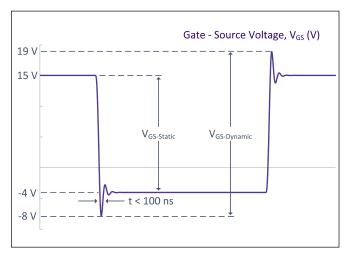
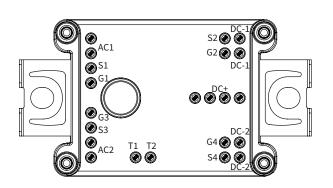
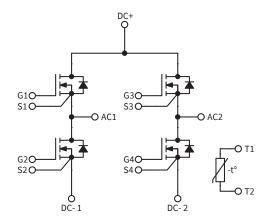


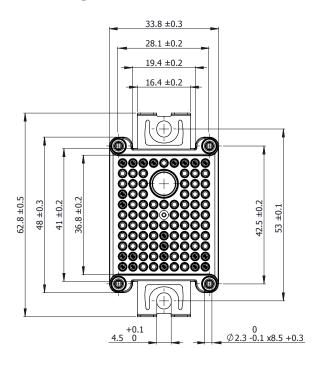
Figure 32. V_{GS} Transient Definitions

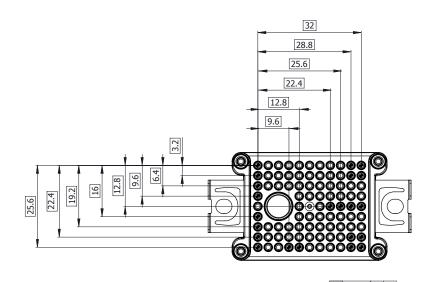
Pinout



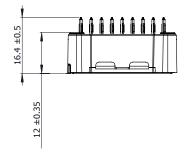


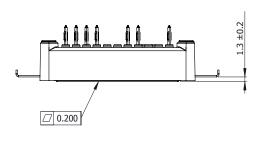
Package Dimension (mm)











Supporting Links & Tools

Evaluation Tools & Support

- KIT-CRD-CIL12N-FMB: Dynamic Evaluation Board for Full-Bridge FM3 Modules
- CBB021M12FM3 PLECS Model
- SpeedFit 2.0 Design Simulator™
- <u>Technical Support Forum</u>

Dual-Channel Gate Driver Board

- EVAL-ADUM4146WHB1Z: Analog Devices® Gate Driver Board
- Si823H-AxWA-KIT: Skyworks® Gate Driver Board
- ACPL-355JC: Broadcom® Gate Driver Board
- CGD1700HB2M-UNA: Wolfspeed Gate Driver Board
- CGD12HB00D: Differential Transceiver Daughter Board Companion Tool for Differential Gate Drivers

Application Notes

- CPWR-AN41: Mounting Instructions and PCB Requirements
- CPWR-AN42: Thermal Interface Material Application Note
- CPWR-AN45: Dynamic Performance Application Note

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Contact info:

4600 Silicon Drive Durham, NC 27703 USA Tel: +1.919.313.5300 www.wolfspeed.com/power